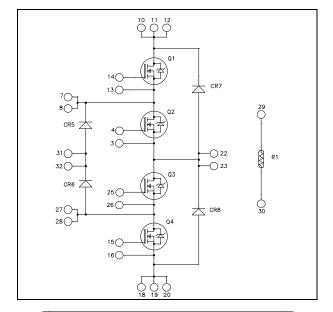


# Three level inverter SiC MOSFET Power Module

### SiC Power MOSFET:

 $V_{DSS} = 1200V ; R_{DSon} = 49m\Omega @ Tj = 25^{\circ}C$ 



### Application

• Uninterruptible Power Supplies

#### **Features**

- SiC Power MOSFET
  - Low R<sub>DS(on)</sub>
  - High temperature performance

#### • SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring
- AlN substrate for improved thermal performance

# 28 27 26 25 23 22 20 19 18 29 29 16 30 15 31 31 14 31 32 13 31

All multiple inputs and outputs must be shorted together 10/11/12; 7/8; 27/28; ...

#### **Benefits**

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of VCEsat
- Low profile
- RoHS Compliant

### All ratings @ $T_i = 25$ °C unless otherwise specified

### Q1 to Q4 Absolute maximum ratings (per SiC MOSFET)

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Breakdown Voltage		1200	V
Ţ	Continuous Drain Current	$T_c = 25^{\circ}C$	55	
$I_D$	Continuous Drain Current	$T_c = 80^{\circ}C$	42	A
$I_{DM}$	Pulsed Drain current	•		
$V_{GS}$	Gate - Source Voltage		-10/+25	V
$R_{DSon}$	Drain - Source ON Resistance		49	$m\Omega$
$P_{D}$	Maximum Power Dissipation	$T_c = 25^{\circ}C$	250	W

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



### Q1 to Q4 Electrical Characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V ; V_{DS} = 1200V$			25	200	μA
D	Drain – Source on Resistance	$V_{GS} = 20V$	$T_j = 25^{\circ}C$		40	49	
$R_{DS(on)}$		$I_D = 40A$	$T_{j} = 150^{\circ}C$		75	104	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 2mA$		1.7	2.2		V
Ices	Gate – Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	7			500	nA

# Q1 to Q4 Dynamic Characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
C <sub>iss</sub>	Input Capacitance	$V_{GS} = 0V$			1900		
$C_{oss}$	Output Capacitance	$V_{DS} = 1000V$			160		pF
$C_{rss}$	Reverse Transfer Capacitance	f = 1MHz			13		
$Q_{g}$	Total gate Charge	$V_{GS} = 20V$	$V_{cs} = 20V$		98		
$Q_{gs}$	Gate – Source Charge	$V_{\text{Bus}} = 800V$			22		nC
$Q_{\text{gd}}$	Gate – Drain Charge	$I_D = 40A$			36		
$T_{d(on)}$	Turn-on Delay Time	V - 5/±20V			12		
$T_{r}$	Rise Time	$V_{\text{GS}} = 37/20 \text{ V}$ $V_{\text{Bus}} = 800 \text{ V}$	$V_{GS} = -5/+20V$ $V_{Bus} = 800V$		14		
$T_{d(off)}$	Turn-off Delay Time	$I_D = 40A$	1		23		ns
$T_{\mathrm{f}}$	Fall Time	$R_{\rm L} = 20\Omega \; ; \; R_{\rm G} = 25$	Ω		18		
E <sub>on</sub>	Turn on Energy	Inductive Switching $V_{GS} = -5/+20V$ $V_{Bus} = 600V$	$T_{\rm j} = 150^{\circ}{ m C}$		0.9		mJ
$E_{\rm off}$	Turn off Energy	$I_{D} = 40A$ $R_{G} = 25\Omega$	$T_j = 150$ °C		0.5		mJ
$R_{\text{thJC}}$	Junction to Case Thermal Resistar	ice				0.5	°C/W

# CR5 & CR6 SiC diode ratings and characteristics (Per SiC diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit	
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage			600			V	
т	Manianana Banana Laglaga Comunit	$V_p=600V$	$T_j = 25$ °C		30	180	4	
$I_{RM}$	Maximum Reverse Leakage Current		V <sub>R</sub> -000 V	$V_R = 000 V$ $T_i = 175^\circ$	$T_j = 175$ °C		60	900
$I_F$	DC Forward Current		Tc = 125°C		30		Α	
V	Die de Ferryand Veltage	$I_{-}=30\Delta$	$T_i = 25^{\circ}C$		1.6	1.8	V	
$V_{\mathrm{F}}$	Diode Forward Voltage		$T_i = 175$ °C		2	2.4	V	
Qc	Total Capacitive Charge	$I_F = 30A, V_R = 600V$ $di/dt = 1000A/\mu s$			84		nC	
С	Total Capacitance	$f = 1MHz, V_R = 200V$		195		ъF		
		$f = 1MHz, V_R =$	400V		150		pF	
$R_{thJC}$	Junction to Case Thermal Resistance	ction to Case Thermal Resistance				0.8	°C/W	

2 - 8



### CR7 & CR8 diode ratings and characteristics (Per SiC diode)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage			1200			V
$I_{RM}$	Maximum Reverse Leakage Current	$V_{R}=1200V$	$T_j = 25$ °C		96	600	μA
KW	č	K	$T_{\rm j} = 175^{\circ}{\rm C}$		168	3000	'
$I_F$	DC Forward Current		Tc = 125°C		30		A
17	Diode Forward Voltage	$I_F = 30A \qquad \frac{T_i = 25^{\circ}C}{T_i = 175^{\circ}C}$		1.6	1.8	V	
$V_{\mathrm{F}}$				2.3	3		
Qc	Total Capacitive Charge	$I_F = 30A, V_R = 1200V$ $di/dt = 1500A/\mu s$			240		nC
C	Total Compaitemen	$f = 1 MHz, V_R = 200V$	200V		288		E
	Total Capacitance	$f = 1 MHz, V_R = 400 V$			207		pF
$R_{\text{thJC}}$	Junction to Case Thermal Resistance					0.50	°C/W

# $Temperature\ sensor\ NTC\ (\text{see application note APT0406 on www.microsemi.com}\ ).$

Symbol	Characteristic			Typ	Max	Unit
R <sub>25</sub>	Resistance @ 25°C	5°C		50		kΩ
$\Delta R_{25}/R_{25}$				5		%
B <sub>25/85</sub>	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		T <sub>C</sub> =100°C		4		%

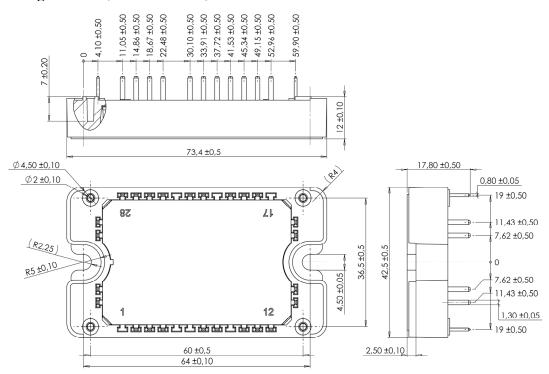
$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature R<sub>T</sub>: Thermistor value at T

# Thermal and package characteristics

Symbol	Characteristic			Min	Typ	Max	Unit
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
Т	On anoting in a tion town another manage		SiC MOSFET	-40		150	
$T_{J}$	Operating junction temperature range  SiC diode		-40		175		
$T_{JOP}$	Recommended junction temperature under switching conditions			-40		T <sub>J</sub> max -25	°C
$T_{STG}$	Storage Temperature Range			-40		125	
$T_{C}$	Operating Case Temperature			-40		125	
Torque	Mounting torque	To heatsink	M4	2		3	N.m
Wt	Package Weight					110	g

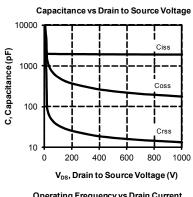


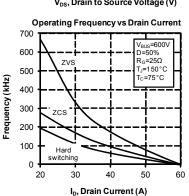
### SP3 Package outline (dimensions in mm)

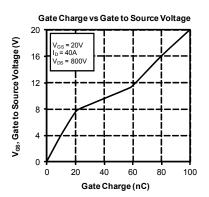


See application note 1906 - Mounting Instructions for SP3F Power Modules on www.microsemi.com

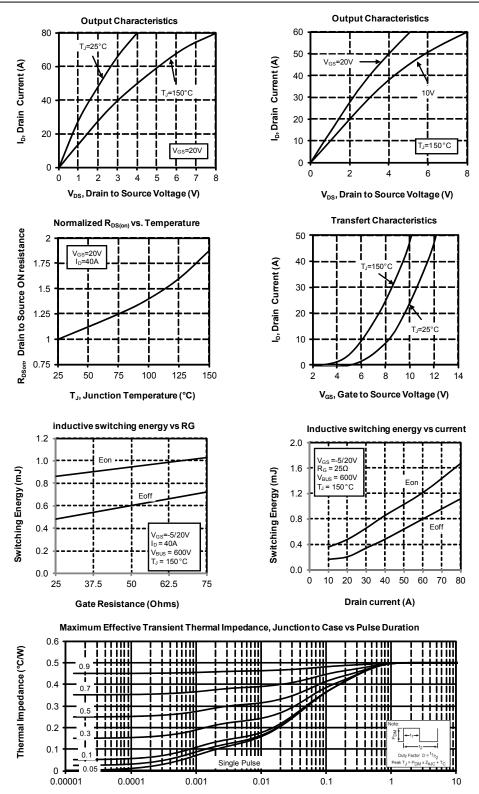
### Q1 to Q4 Typical performance curve









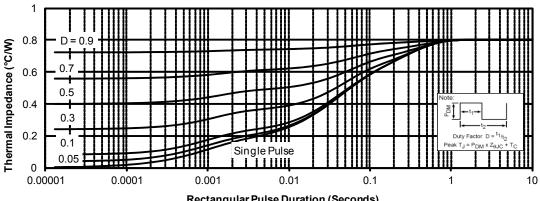


rectangular Pulse Duration (Seconds)

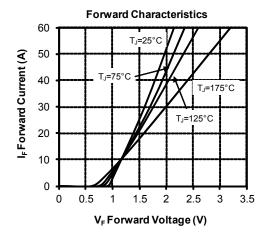


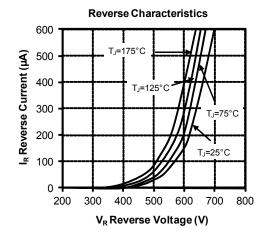
# CR5 & CR6 Typical performance curve

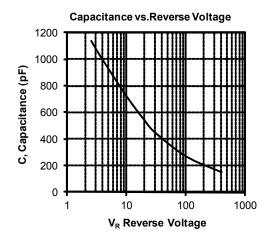
#### Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



Rectangular Pulse Duration (Seconds)



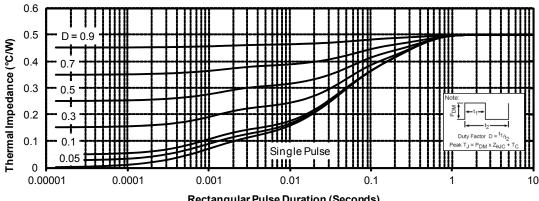




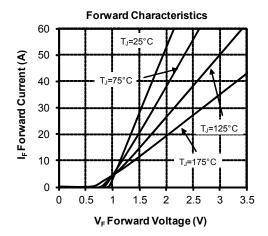


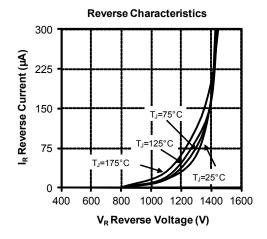
# CR7 & CR8 Typical performance curve

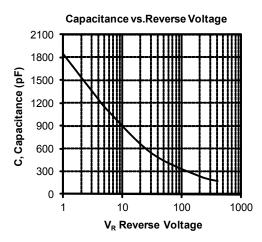
#### Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



Rectangular Pulse Duration (Seconds)







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